## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10762174	SATOH ET AL.
Examiner	Art Unit
Tan V Mai	2193

SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NOTES				
Search Notes	Date	Examiner		
Appeal Conference, SPE Lewis Bullock & Eddie Lee	2/25/08	TM		

INTERFERENCE SEARCH					
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